


<b>Search Notes</b>  	<b>Application/Control No.</b>  10572525	<b>Applicant(s)/Patent Under Reexamination</b>  KANG ET AL.
	<b>Examiner</b>  KHIEM D NGUYEN	<b>Art Unit</b>  2823

SEARCHED			
Class	Subclass	Date	Examiner
438	15,26,122,612	4/27/2009	/KN/
257	67,E21.476,E21.506,E21.531,E29.089,E33.075,E21.531	4/27/2009	/KN/
438	22, 29, 122	6/3/2011	/KN/
257	E33.001, E33.075	6/3/2011	/KN/

SEARCH NOTES		
Search Notes	Date	Examiner
EAST text search (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB), see attached search history.	4/27/2009	/KN/
EAST text search (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB), see attached search history.	4/21/2010	/KN/
EAST text search (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB), see attached search history.	6/3/2011	/KN/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	Claims interference searched (US-PGPUB; USPAT; UPAD), see attached search history.	6/3/2011	/KN/

	/KHIEM D NGUYEN/ Primary Examiner.Art Unit 2823
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